onsemi

MOSFET – N-Channel, QFET[®]

V _{DSS}	V _{DSS} R _{DS(ON)} MAX I _D	
600 V	4.7 Ω @ 10 V	1.9 A

600 V, 1.9 A, 4,7 Ω

FQD2N60C / FQU2N60C

This N-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

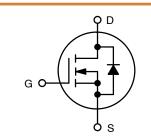
Features

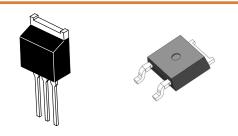
- 1.9 A, 600 V, $R_{DS(on)}$ = 4.7 Ω (Max.) @ V_{GS} = 10 V, I_D = 0.95 A
- Low Gate Charge (Typ. 8.5 nC)
- Low Crss (Typ. 4.3 pF)
- 100% Avalanche Tested
- These Devices are Halid Free and are RoHS Compliant

MAXIMUM RATINGS (T_C = 25° C unless otherwise noted)

Symbol	Rating	Value	Unit
V _{DSS}	Drain-Source Voltage	600	V
Ι _D	Drain Current – Continuous (T _C = 25°C) – Continuous (T _C = 100°C)	1.9 1.14	Α
I _{DM}	Drain Current – Pulsed (Note 1)	7.6	А
V _{GSS}	Gate-Source Voltage	±30	V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	120	mJ
I _{AR}	Avalanche Current (Note 1)	1.9	А
E _{AR}	Repetitive Avalanche Energy (Note 1)	4.4	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.5	V/ns
PD	Power Dissipation ($T_A = 25^{\circ}C$) *	2.5	W
	Power Dissipation (T _C = 25°C) – Derate above 25°C	44 0.35	W W/°C
T _J , T _{STG}	Operating and Storage Temperature Range	–55 to +150	°C
TL	Maximum Lead Temperature for Soldering Purposes, 1/8" (from case for 5 seconds)	300	°C

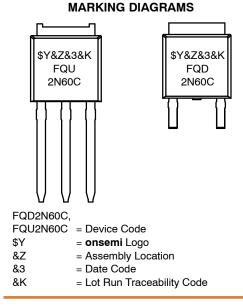
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.





DPAK3 (IPAK) CASE 369AR

DPAK3 (TO-252 3 LD) CASE 369AS



ORDERING INFORMATION

Device	Package	Shipping [†]
FQD2N60CTM	DPAK3 (TO-252 3 LD) (Pb-Free)	2500 / Tape & Reel
FQU2N60CTU	DPAK3 (IPAK) (Pb-Free)	70 Units / Tube

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, <u>BRD8011/D</u>.

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THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	2.87	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (minimum pad of 2 oz copper), Max.	110	°C/W
	Thermal Resistance, Junction-to-Ambient (* 1 in ² pad of 2 oz copper), Max.	50	

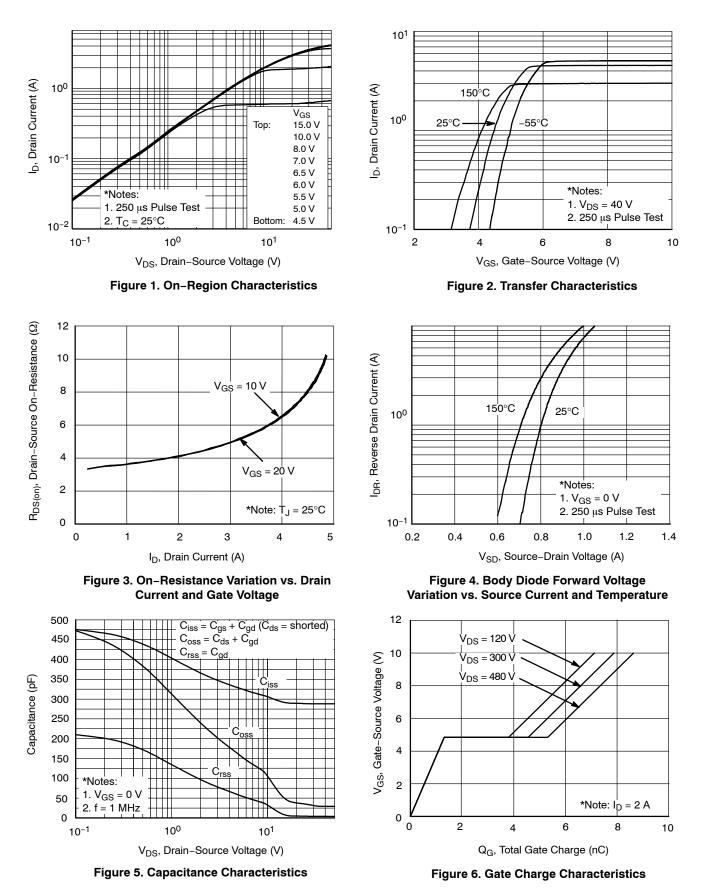
ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
OFF CHARA	ACTERISTICS	·				
BV _{DSS}	Drain-to-Source Breakdown Voltage	$I_{D} = 250 \ \mu A, \ V_{GS} = 0 \ V$	600	-	-	V
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta \text{T}_{\text{J}}}/$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C	-	0.6	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μA
		$V_{DS} = 480 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$	-	-	10	
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$	-	-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	-100	nA
ON CHARAG	CTERISTICS	-	•			
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2.0	-	4.0	V
R _{DS(on)}	Static Drain-Source On Resistance	V_{GS} = 10 V, I _D = 0.95 A	-	3.6	4.7	Ω
9 FS	Forward Transconductance	$V_{DS} = 40 \text{ V}, \text{ I}_{D} = 0.95 \text{ A}$	-	5.0	-	S
DYNAMIC C	HARACTERISTICS				-	
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$	-	180	235	pF
C _{oss}	Output Capacitance	f = 1.0 MHz	-	20	25	
C _{rss}	Reverse Transfer Capacitance	7	-	4.3	5.6	
SWITCHING	CHARACTERISTICS	-				
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 300 \text{ V}, \text{ I}_{D} = 2 \text{ A},$	-	9	28	ns
t _r	Turn-On Rise Time	$R_{G} = 25 \Omega$ (Note 4)	-	25	60	
t _{d(off)}	Turn-Off Delay Time	7	-	24	58	
t _f	Turn-Off Fall Time	7	-	28	66	
Qg	Total Gate Charge	V _{DS} = 480 V, I _D = 2 A,	-	8.5	12	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V (Note 4)	-	1.3	-	
Q _{gd}	Gate-Drain Charge	1	-	4.1	-	
DRAIN-SOL	JRCE DIODE CHARACTERISTICS AND MA	AXIMUM RATINGS				
I _S	Maximum Continuous Drain-Source Diode Forward Current		-	-	1.9	Α
1	Maximum Buland Drain, Source Diado Forward Current			1	7.6	^

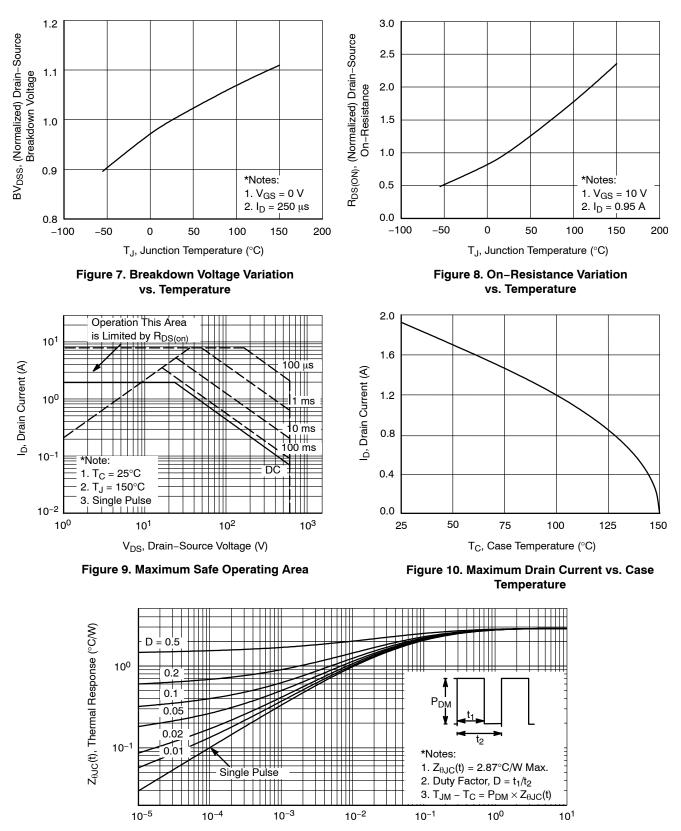
IS	Maximum Continuous Drain-Source Diode Forward Current		-	-	1.9	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-	-	7.6	А
V _{SD}	Drain–Source Diode Forward Voltage $V_{GS} = 0 V$, $I_S = 1.6 A$		-	-	1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 2 A, dI _E /dt = 100 A/μs	-	230	-	ns
Q _{rr}	Reverse Recovery Charge	$di F/dt = 100 A/\mu S$	-	1.0	-	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product Product parametric performance is indicated in the Electrical Characteristics for the listed test condition performance may not be indicated by the Electrical Characteristics if operated under different conditions. 1. Repetitive Rating : Pulse width limited by maximum junction temperature. 2. L = 56 mH, $I_{AS} = 2 \text{ A}$, $V_{DD} = 50 \text{ V}$, $R_G = 25 \Omega$, Starting $T_J = 25^{\circ}\text{C}$. 3. $I_{SD} \le 2.0 \text{ A}$, di/dt $\le 200 \text{A}/\mu\text{s}$, $V_{DD} \le \text{BV}_{DSS}$, Starting $T_J = 25^{\circ}\text{C}$. 4. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS (continued)



t₁, Square Wave Pulse Duration (s)

Figure 11. Transient Thermal Response Curve

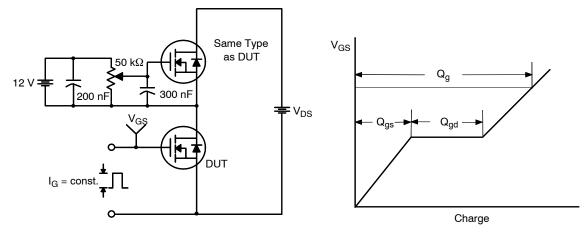


Figure 12. Gate Charge Test Circuit & Waveform

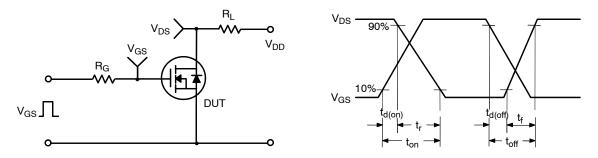


Figure 13. Resistive Switching Test Circuit & Waveforms

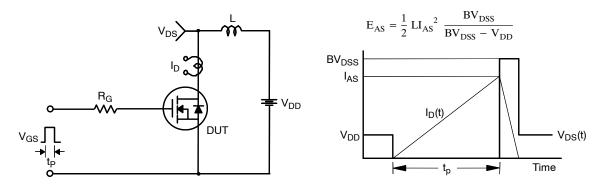


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

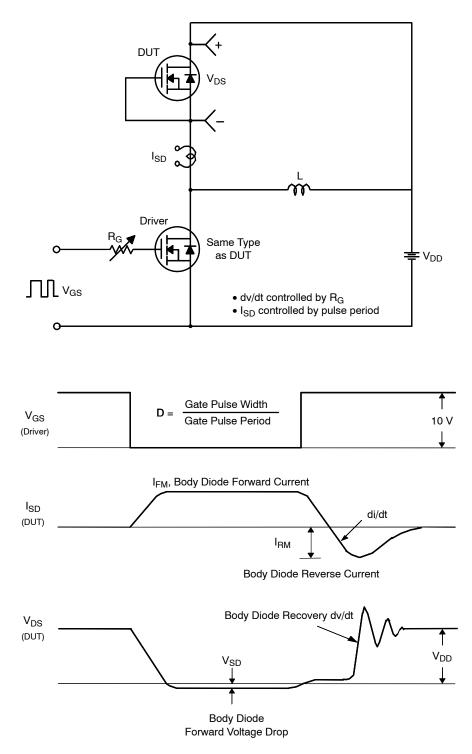


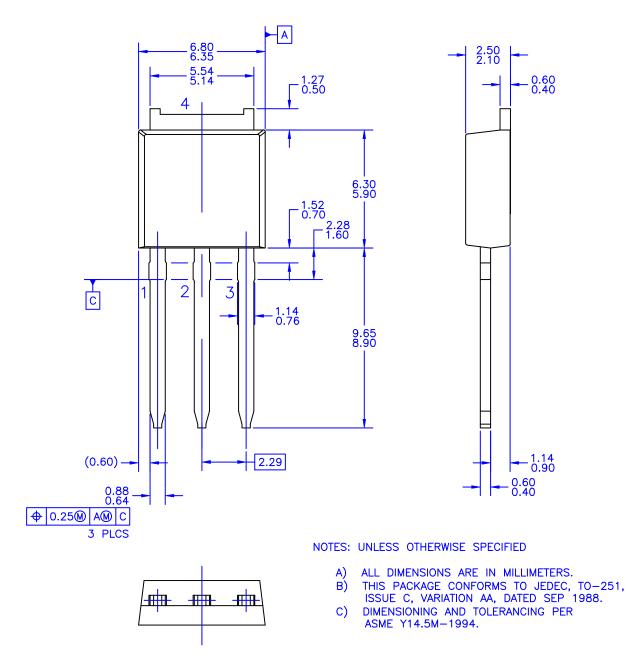
Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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DATE 30 SEP 2016

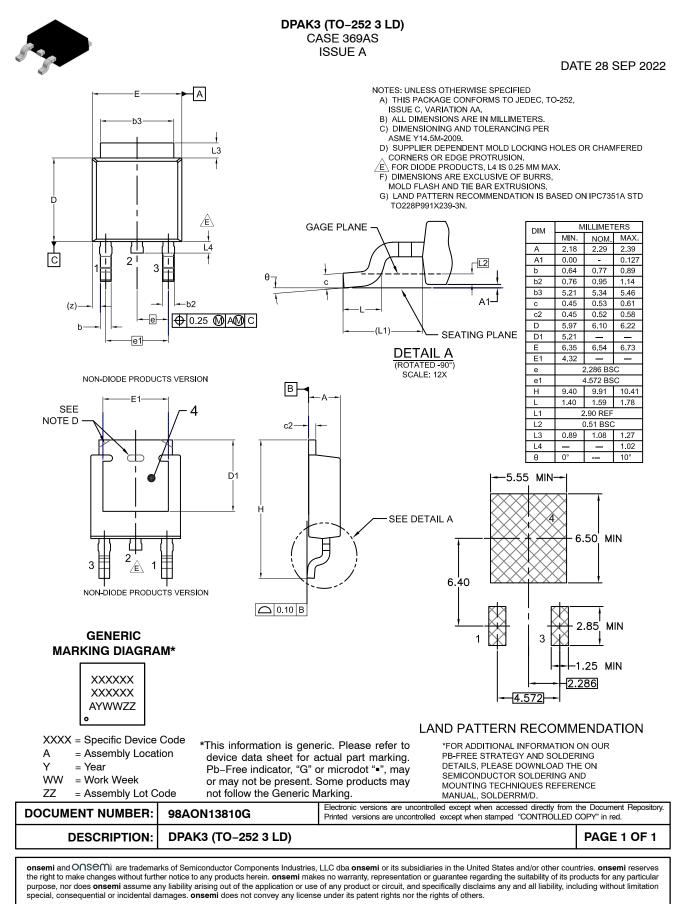


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